

Attorney Docket No. 01250/LH

**IN THE UNITED STATES PATENT
AND TRADEMARK OFFICE**

Applicant(s): H. TAJIMA et al

Serial No. :

Filed : Herewith

For : SAMPLE CHIP ANALYZING
DEVICE AND METHOD
FOR ANALYZING THE
SAME

Art Unit :
Examiner :

PRELIMINARY AMENDMENT

Asst. Commissioner for Patents
Washington, D.C. 20231

S I R :

Please amend the above-identified application as follows:

IN THE CLAIMS:

Please substitute the following amended claims 3-6 for the
original claims 3-6:

3. (amended) The sample chip analyzing device and method for
analyzing a sample chip according to Claim 1, wherein said
waveguide plate is a glass substrate.

4. (amended) The sample chip analyzing device and method for
analyzing the sample chip according to Claim 1, wherein said
waveguide plate has a pair of insulation reflection plates
arranged opposite to each other with an appointed interval.

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Barbara Villani
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R. Talbot